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Using Synthetic Data**

Biswajit Basak<sup>1</sup>,  
Bimal Sinha<sup>2, 3</sup>

<sup>1</sup>Department of Statistics, Sister Nivedita University, Kolkata, India

<sup>2</sup>University of Maryland, Baltimore County, Maryland, USA

<sup>3</sup>Center for Statistical Research and Methodology, U.S. Census Bureau, USA

Center for Statistical Research & Methodology  
Research and Methodology Directorate  
U.S. Census Bureau  
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# Analysis of One-Way ANOVA Model using Synthetic Data

Biswajit Basak<sup>1</sup> and Bimal Sinha <sup>\*2,3</sup>

<sup>1</sup>Department of Statistics, Sister Nivedita University, Kolkata, India

<sup>2</sup>University of Maryland, Baltimore County, Maryland, USA

<sup>3</sup>Center for Statistical Research and Methodology, U.S. Census Bureau, Washington, DC 20233, USA

## Abstract

In this paper we consider the age-old ANOVA problem of testing the equality of means of several univariate normal populations with a common unknown variance, except that the data used for analysis arise from a synthetic version of the original observations. We address two versions of the synthetic data: one obtained under Plug-In sampling(PIS) method and the other under Posterior Predictive Sampling(PPS) method. We study its distributional properties (null and non-null) and provide enough computational details. A comparison of power is also provided. As expected, the power under the PIS method is more than that under the PPS method. A measure of privacy protection is also evaluated and it turns out that the PIS method provides less protection than the PPS method, thus confirming the standard belief that accuracy of inference and privacy protection work in opposite directions!

**Keywords:** ANOVA problem, non-central F distribution, plug-in sampling, posterior predictive sampling

## 1 Introduction

Statistical agencies dealing with collection and publication of relevant data often face the problem of releasing microdata for public use in view of compromising with the privacy of survey respondents. Most often therefore data are summarized and presented in tabular forms. However, some data users and policy stakeholders may also want to use the microdata to carry out other forms of data analysis, different from what the agencies release. This calls for release of microdata under some perturbation mechanism to ensure privacy protection. Statistical literature is quite rich in terms of data perturbation methods and subsequent data analysis techniques based on perturbed data. Some commonly used data perturbation methods include: noise addition/multiplication (Nayak, Zayatz and Sinha, 2011, [1], [2]; Klein and Sinha, 2013 [3]; Mathew, Klein and Sinha, 2014 [4]), model-based multiply imputed synthetic data methods (Drechsler, 2011 [5]; Raghunathan et al., 2003 [7]; Reiter, 2003 [8]; Reiter and Kinney, 2012 [9]). While the inferential methods developed by Reiter et al (2003, 2004, 2005(a),(b),(c), 2012, [8], [9], [10], [11], [12], [13]) are essentially asymptotic in nature, Klein and Sinha (2015 [14], [15], 2016 [16]) developed exact data analysis methods for singly imputed synthetic data based on some simple parametric models under two popular types of synthetic data generation.

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\*Corresponding author :

Bimal Sinha, University of Maryland, Baltimore County, Maryland, USA and Center for Statistical Research and Methodology, U.S. Census Bureau, Washington, DC 20233, USA. Email: sinha@umbc.edu

In this paper we consider the age-old ANOVA problem of testing the equality of means of several univariate normal populations with a common unknown variance, except that the data used for analysis arise from a synthetic version of the original observations. Consider  $k$  random samples  $\mathbf{x}_1, \mathbf{x}_2, \dots, \mathbf{x}_k$  where the  $i^{th}$  sample  $\mathbf{x}_i = (x_{i1}, x_{i2}, \dots, x_{in_i})$ ,  $i = 1, 2, \dots, k$ , is coming from  $N(\mu_i, \sigma^2)$  distribution. Define  $N = \sum_{i=1}^k n_i$ ,  $\bar{x}_i = \frac{1}{n_i} \sum_{j=1}^{n_i} x_{ij}$ ,  $\bar{x}_w = \frac{1}{N} \sum_{i=1}^k n_i \bar{x}_i$ , and  $S_x^2 = \sum_{i=1}^k \sum_{j=1}^{n_i} (x_{ij} - \bar{x}_i)^2$ . Our main objective is to develop a testing strategy to test the equality of these  $k$  means, which is given by

$$H_0 : \mu_1 = \mu_2 = \dots = \mu_k \quad \text{against} \quad H_1 : \text{Atleast one inequality in } H_0. \quad (1)$$

It is well known that, based on the original data  $\mathbf{x} = (\mathbf{x}_1, \mathbf{x}_2, \dots, \mathbf{x}_k)$ , the likelihood ratio test (LRT) is provided by the standard  $F$ -statistic defined as  $F_x = \left( \frac{N-k}{k-1} \right) \frac{\text{BSS}}{\text{WSS}}$ , where  $\text{BSS} = \sum_{i=1}^k n_i (\bar{x}_i - \bar{x}_w)^2$  and  $\text{WSS} = S_x^2 = \sum_{i=1}^k \sum_{j=1}^{n_i} (x_{ij} - \bar{x}_i)^2$ .

Our goal is now to suitably perturb the original data in view of privacy protection requirement and provide appropriate analysis of the resultant perturbed data. As mentioned earlier, there are a variety of methods in the statistics literature to accomplish this task. Here we consider two methods of generating synthetic data and provide appropriate valid inference for testing  $H_0$  based on both types of synthetic data. In Section 2 we discuss Plug-In Sampling method while in Section 3 the Posterior Predictive Sampling method. Our inference is essentially based on the usual  $F$ -statistic based on the synthetic data and we study its distributional properties (null and non-null) in both the cases. Computational details and a comparison of power are provided in Section 4. Section 5 is devoted to a discussion of privacy protection offered by the above data perturbation methods. As expected, PIS offers better inference and less privacy protection compared to PPS.

## 2 Plug-In Sampling(PIS) Method

Here we consider the unbiased estimates of  $\mu_i$ 's ( $i = 1, 2, \dots, k$ ) and  $\sigma^2$  based on the original data  $\mathbf{x} = (\mathbf{x}_1, \mathbf{x}_2, \dots, \mathbf{x}_k)$ , as  $\hat{\mu}_i = \bar{x}_i$  and  $\hat{\sigma}^2 = \frac{S_x^2}{N-k}$ , and hence draw  $k$  independent samples  $\mathbf{y}_1, \mathbf{y}_2, \dots, \mathbf{y}_k$  where the  $i^{th}$  sample  $\mathbf{y}_i = (y_{i1}, y_{i2}, \dots, y_{in_i})$  is a random sample from  $N(\bar{x}_i, \hat{\sigma}^2)$  distribution. Define  $\bar{y}_i = \frac{1}{n_i} \sum_{j=1}^{n_i} y_{ij}$ ,  $\bar{y}_w = \frac{1}{N} \sum_{i=1}^k n_i \bar{y}_i$ , Within Sum of Squares( $\text{WSS}(\mathbf{y})$ ) =  $S_y^2 = \sum_{i=1}^k \sum_{j=1}^{n_i} (y_{ij} - \bar{y}_i)^2$ , and Between Sum of Squares( $\text{BSS}(\mathbf{y})$ ) =  $\sum_{i=1}^k n_i (\bar{y}_i - \bar{y}_w)^2$ . Note that  $\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2$  are jointly sufficient for  $(\mu_1, \mu_2, \dots, \mu_k, \sigma^2)$  based on the synthetic data  $\mathbf{y} = (\mathbf{y}_1, \mathbf{y}_2, \dots, \mathbf{y}_k)$  obtained by the above method (see Klein and Sinha, 2015 [14] for a very general method). Next we consider the joint pdf of the sufficient statistic  $(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2)$  in the following theorem.

**Theorem 2.1.** *The joint pdf of  $(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2)$  is given by*

$$f(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2) \propto \frac{1}{(\sigma^2)^{\frac{N-1}{2}}} \int_0^\infty \frac{(S_y^2)^{\frac{N-k-2}{2}} (S_x^2)^{-(\frac{K+1}{2})}}{\left( \sigma^2 + \frac{S_x^2}{N-k} \right)^{\frac{1}{2}}} \\ \times \exp \left[ -\frac{1}{2} \left\{ \frac{S_x^2}{\sigma^2} + \frac{(N-k)S_y^2}{S_x^2} + \frac{\sum_{i=1}^k n_i (\bar{y}_i - \mu_i)^2}{\left( \sigma^2 + \frac{S_x^2}{N-k} \right)} \right\} \right] dS_x^2$$

*Proof.* Starting from the fact that  $\bar{x}_i \sim N(\mu_i, \frac{\sigma^2}{n_i})$  independently for each  $i = 1, 2, \dots, k$ , and  $\frac{S_x^2}{\sigma^2} \sim \chi_{N-k}^2$  independently of each  $\bar{x}_i$ , we can write the joint pdf of  $(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2)$  as given by,

$$f(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \propto \frac{(S_x^2)^{\frac{N-k}{2}-1} e^{-\frac{1}{2\sigma^2} [S_x^2 + \sum_{i=1}^k n_i (\bar{x}_i - \mu_i)^2]}}{(\sigma^2)^{\frac{N}{2}}}.$$

Conditionally given  $(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2)$ ,

$$\bar{y}_i \sim N \left( \bar{x}_i, \frac{\hat{\sigma}^2}{n_i} \right), \text{ independently for } i = 1, 2, \dots, k,$$

$S_y^2 \sim \hat{\sigma}^2 \chi_{N-k}^2$ , independently of each  $\bar{y}_i$ .

Therefore the conditional pdf of  $(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2 | \bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2)$  is given by,

$$f(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2 | \bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \propto \frac{(S_y^2)^{\frac{N-k}{2}-1} e^{-\frac{1}{2\hat{\sigma}^2} [S_y^2 + \sum_{i=1}^k n_i (\bar{y}_i - \bar{x}_i)^2]}}{(\hat{\sigma}^2)^{\frac{N}{2}}}.$$

The joint pdf of  $(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2)$  can be expressed as,

$$\begin{aligned} f(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2) &= \int_{\bar{x}_1} \int_{\bar{x}_2} \dots \int_{\bar{x}_k} \int_0^\infty f(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2 | \bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \\ &\quad \times f(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) d\bar{x}_1 d\bar{x}_2 \dots d\bar{x}_k dS_x^2 \\ &\propto \frac{1}{(\sigma^2)^{\frac{N}{2}}} \int_{\bar{x}_1} \int_{\bar{x}_2} \dots \int_{\bar{x}_k} \int_0^\infty (S_y^2)^{\frac{N-k}{2}-1} (S_x^2)^{-(\frac{k+2}{2})} \\ &\quad \times e^{-\frac{1}{2} \left[ \frac{S_x^2 + \sum_{i=1}^k n_i (\bar{x}_i - \mu_i)^2}{\sigma^2} + \frac{S_y^2 + \sum_{i=1}^k n_i (\bar{y}_i - \bar{x}_i)^2}{\hat{\sigma}^2} \right]} d\bar{x}_1 d\bar{x}_2 \dots d\bar{x}_k dS_x^2. \end{aligned}$$

We see that

$$\begin{aligned} &\frac{\sum_{i=1}^k n_i (\bar{y}_i - \bar{x}_i)^2}{\hat{\sigma}^2} + \frac{\sum_{i=1}^k n_i (\bar{x}_i - \mu_i)^2}{\sigma^2} \\ &= \frac{\sum_{i=1}^k n_i (\bar{y}_i - \mu_i)^2}{\sigma^2 + \hat{\sigma}^2} + \left( \frac{1}{\sigma^2} + \frac{1}{\hat{\sigma}^2} \right) \sum_{i=1}^k n_i \left[ \bar{x}_i - \mu_i - \frac{\bar{y}_i - \mu_i}{\hat{\sigma}^2 (\frac{1}{\sigma^2} + \frac{1}{\hat{\sigma}^2})} \right]^2 \end{aligned}$$

Hence after integrating out  $\bar{x}_i$ 's the joint pdf reduces to

$$f(\bar{y}_1, \bar{y}_2, \dots, \bar{y}_k, S_y^2) \propto \frac{1}{(\sigma^2)^{\frac{N}{2}}} \int_0^\infty \frac{(S_y^2)^{\frac{N-k}{2}-1} (S_x^2)^{-(\frac{k+2}{2})}}{\left( \frac{1}{\sigma^2} + \frac{1}{\hat{\sigma}^2} \right)^{\frac{1}{2}}} e^{-\frac{1}{2} \left[ \frac{S_x^2}{\sigma^2} + \frac{S_y^2}{\hat{\sigma}^2} + \frac{\sum_{i=1}^k n_i (\bar{y}_i - \mu_i)^2}{\sigma^2 + \hat{\sigma}^2} \right]} dS_x^2.$$

Finally we put  $\hat{\sigma}^2 = \frac{S_x^2}{N-k}$  in the above form and hence the result follows. [Theorem (2.1) is proved]

The inferential results are discussed in the following remarks.

**Remark 2.1.** Following  $F_x$ , we define the test statistic  $F_y = \left( \frac{N-k}{k-1} \right) \frac{\text{BSS}(\mathbf{y})}{\text{WSS}(\mathbf{y})}$ , based on the PIS synthetic data, and a level  $\gamma$  test based on the synthetic data  $\mathbf{y}$  for the testing problem (1) is given by  $F_y > C_{N,k,\gamma}$ , where  $C_{N,k,\gamma}$  is such that  $P[F_y > C_{N,k,\gamma} | H_0] = \gamma$ . We obtain  $C_{N,k,\gamma}$  by the following steps:

1. We consider the conditional distribution of  $F_y | \mathbf{x}$  which follows a non-central  $F$ -distribution with degrees of freedom  $(k-1, N-k)$  and the non centrality parameter being  $\lambda_x = \frac{\sum_{i=1}^k n_i (\bar{x}_i - \bar{x}_w)^2}{\hat{\sigma}^2}$  where  $\bar{x}_w = \frac{1}{N} \sum_{i=1}^k n_i \bar{x}_i$ . Again  $\frac{\sum_{i=1}^k n_i (\bar{x}_i - \bar{x}_w)^2}{\sigma^2}$  follows a non-central chi square distribution with  $k-1$  degrees of freedom and the non centrality parameter being  $\lambda = \frac{\sum_{i=1}^k n_i (\mu_i - \bar{\mu}_w)^2}{\sigma^2}$  where  $\bar{\mu}_w = \frac{1}{N} \sum_{i=1}^k n_i \mu_i$ . Note that  $\lambda = 0$  under  $H_0$  and hence  $\frac{\sum_{i=1}^k n_i (\bar{x}_i - \bar{x}_w)^2}{\sigma^2} \sim \chi_{k-1}^2$  under  $H_0$ . Also  $\hat{\sigma}^2 = \frac{S_x^2}{N-k} \sim \frac{\sigma^2}{N-k} \chi_{N-k}^2$  which is independently distributed with  $\frac{\sum_{i=1}^k n_i (\bar{x}_i - \bar{x}_w)^2}{\sigma^2}$ , therefore  $\lambda_x$  follows a  $(k-1)$  times non-central  $F$ -distribution with parameters  $(k-1, N-k)$  and the non centrality parameter be  $\lambda$  and  $\lambda_x \sim (k-1)F_{k-1, N-k}$  under  $H_0$ .
2. Note that  $\gamma = P[F_y > C_{N,k,\gamma} | H_0]$ , which can be written as,

$$\begin{aligned} \gamma &= P[F_y > C_{N,k,\gamma} | H_0] \\ &= E_{H_0} [P(F_y > C_{N,k,\gamma} | \mathbf{x})] \\ &= E_{H_0} [P((k-1)F_{k-1, N-k}(\lambda_x) > C_{N,k,\gamma} | \mathbf{x})] \end{aligned}$$

$$= E_{H_0} \left[ e^{-\frac{\lambda_x}{2}} \sum_{j=0}^{\infty} \frac{(\frac{\lambda_x}{2})^j}{j!} \frac{k+2j-1}{k-1} P(F_{k+2j-1, N-k} > C_{N,k,\gamma}) \right]$$

where  $F_{k-1, N-k}(\lambda_x)$  is a non-central  $F$ -variate with degrees of freedom  $(k-1, N-k)$  with non centrality parameter  $\lambda_x$  and  $F_{k+2j-1, N-k}$  be a central  $F$ -variate with degrees of freedom  $(k+2j-1, N-k)$ .

3. For a fixed  $C$  we can compute the expectation under  $H_0$  by generating a large number of  $\lambda_x$ 's as  $\lambda_x \sim (k-1)F_{k-1, N-k}$  under  $H_0$ , and compute the the quantity inside the expectation for each of those  $\lambda_x$ 's and take the arithmetic mean to get the expectation.
4. Finally we numerically solve  $E_{H_0} \left[ e^{-\frac{\lambda_x}{2}} \sum_{j=0}^{\infty} \frac{(\frac{\lambda_x}{2})^j}{j!} \frac{k+2j-1}{k-1} P(F_{k+2j-1, N-k} > C) \right] - \gamma = 0$  for  $C$  to get the cutoff  $C_{N,k,\gamma}$ .

Different cutoff values ( $C_{N,k,\gamma}$ 's) for different sets of sample sizes under fixed  $k$  and  $\gamma$  are given in section 4.

**Remark 2.2.** The power of the test proposed in remark (2.1) for a fixed alternative point  $\boldsymbol{\mu} = (\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$  and  $\sigma = 1$  from  $H_1$  is given by  $\beta_{\text{PIS}}(\boldsymbol{\mu}) = P[F_y > C_{N,k,\gamma} | \boldsymbol{\mu}]$ .  $\beta_{\text{PIS}}(\boldsymbol{\mu})$  is calculated by Monte Carlo simulation technique. We generate a large number ( $10^6$ ) of synthetic data sets and obtain the value of the test statistic for each of those data sets, then find the proportion of the values which are greater than  $C_{N,k,\gamma}$ . The powers for different choices of alternatives are given in section 4.

### 3 Posterior Predictive Sampling(PPS) Method

We assume a joint prior density of  $(\mu_i, \sigma^2)$  as  $\pi(\mu, \sigma^2) \propto (\sigma)^{-\alpha}$  for each  $i = 1, 2, \dots, k$ , where  $N + \alpha > 7$ . A synthetic data under this method can be obtained using the following steps.

1. First we draw  $(\sigma^*)^2$  such that  $\frac{S_x^2}{(\sigma^*)^2} \sim \chi_{N+\alpha-3}^2$ .
2. Draw  $\mu_i^* | (\sigma^*)^2 \sim N(\bar{x}_i, \frac{(\sigma^*)^2}{n_i})$ , independently for each  $i = 1, 2, \dots, k$ .
3. Finally draw  $\mathbf{z}_i = (z_{i1}, z_{i2}, \dots, z_{in_i})$  where  $z_{ij}$ 's ( $j = 1, 2, \dots, n_i$ ) are iid  $N(\mu_i^*, (\sigma^*)^2)$ , independently for each  $i = 1, 2, \dots, k$ .

Here  $\mathbf{z} = (\mathbf{z}_1, \mathbf{z}_2, \dots, \mathbf{z}_k)$  constitutes the synthetic data obtained under PPS sampling method. Similar to the Plug-In sampling method which is discussed in section 2, here we define  $\bar{z}_i = \frac{1}{n_i} \sum_{j=1}^{n_i} z_{ij}$ ,  $\bar{z}_w = \frac{1}{N} \sum_{i=1}^k n_i \bar{z}_i$ , Within Sum of Squares( $\text{WSS}(\mathbf{z}) = S_z^2 = \sum_{i=1}^k \sum_{j=1}^{n_i} (z_{ij} - \bar{z}_i)^2$ , and Between Sum of Squares( $\text{BSS}(\mathbf{z}) = \sum_{i=1}^k n_i (\bar{z}_i - \bar{z}_w)^2$ ). Likewise the case of PIS, here  $\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2$  are jointly sufficient for  $(\mu_1, \mu_2, \dots, \mu_k, \sigma^2)$  based on the synthetic data  $\mathbf{z} = (\mathbf{z}_1, \mathbf{z}_2, \dots, \mathbf{z}_k)$  obtained by the above method (see Klein and Sinha, 2015 [14]).

**Theorem 3.1.** The joint pdf of  $(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2)$  is given by

$$f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \propto \frac{(S_z^2)^{\frac{N-k}{2}-1}}{(\sigma^2)^{\frac{N}{2}}} \int_0^\infty \frac{\psi^{\frac{2N+\alpha-5}{2}} e^{-\frac{\psi}{2\sigma^2} [S_z^2 + \frac{1}{2+\psi} \sum_{i=1}^k n_i (\bar{z}_i - \mu_i)^2]}{(1+\psi)^{\frac{2N+\alpha-k-3}{2}} (2+\psi)^{\frac{k}{2}}} d\psi$$

where  $\psi = \frac{\sigma^2}{(\sigma^*)^2}$ .

*Proof.* We start with the joint pdf of  $(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2)$  as given by,

$$f(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \propto \frac{(S_x^2)^{\frac{N-k}{2}-1} e^{-\frac{1}{2\sigma^2} [S_x^2 + \sum_{i=1}^k n_i (\bar{x}_i - \mu_i)^2]}}{(\sigma^2)^{\frac{N}{2}}}.$$

Next we note that  $\mu_i^*$ 's ( $i = 1, 2, \dots, k$ ) and  $(\sigma^*)^2$  are generated as mentioned in Steps 1. and 2. of section 3, and therefore the joint pdf of  $(\mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2)$  conditionally for given  $(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2)$  is given by,

$$f(\mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2 | \bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \propto \frac{(S_x^2)^{\frac{N+\alpha-3}{2}} e^{-\frac{1}{2(\sigma^*)^2} [S_x^2 + \sum_{i=1}^k n_i (\mu_i^* - \bar{x}_i)^2]}}{\{(\sigma^*)^2\}^{\frac{N+\alpha+k-3}{2}+1}}.$$

Again conditionally given  $(\mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2)$ ,

$$\bar{z}_i \sim N\left(\mu_i^*, \frac{(\sigma^*)^2}{n_i}\right), \text{ independently for } i = 1, 2, \dots, k,$$

$$S_z^2 \sim (\sigma^*)^2 \chi_{N-k}^2, \text{ independently of each } \bar{z}_i.$$

Therefore the conditional pdf of  $(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2 | \mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2)$  is given by,

$$f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2 | \mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2) \propto \frac{1}{\{(\sigma^*)^2\}^{\frac{N}{2}}} (S_z^2)^{\frac{N-k}{2}-1} e^{-\frac{1}{2(\sigma^*)^2} [S_z^2 + \sum_{i=1}^k n_i (\bar{z}_i - \mu_i^*)^2]}$$

We can write the joint pdf of  $(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2)$  as,

$$\begin{aligned} & f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \\ & \propto \int_{\mu_1^*} \int_{\mu_2^*} \dots \int_{\mu_k^*} \int_{\bar{x}_1} \int_{\bar{x}_2} \dots \int_{\bar{x}_k} \int_0^\infty \int_0^\infty f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2 | \mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2) \\ & \times f(\mu_1^*, \mu_2^*, \dots, \mu_k^*, (\sigma^*)^2 | \bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) f(\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k, S_x^2) \left( \prod_{i=1}^k d\mu_i^* \right) \left( \prod_{i=1}^k d\bar{x}_i \right) dS_z^2 d(\sigma^*)^2 \\ & \propto \int_{\mu_1^*} \int_{\mu_2^*} \dots \int_{\mu_k^*} \int_{\bar{x}_1} \int_{\bar{x}_2} \dots \int_{\bar{x}_k} \int_0^\infty \int_0^\infty \frac{(S_z^2)^{\frac{N-k}{2}-1} (S_x^2)^{\frac{2N+\alpha-k-5}{2}}}{(\sigma^2)^{\frac{N}{2}} \{(\sigma^*)^2\}^{\frac{2N+\alpha+k-1}{2}}} e^{-\frac{S_z^2}{2(\sigma^*)^2}} e^{-\left[\frac{1}{\sigma^2} + \frac{1}{(\sigma^*)^2}\right] \frac{S_x^2}{2}} \\ & \times e^{-\frac{1}{2\sigma^2} \sum_{i=1}^k n_i (\bar{x}_i - \mu_i)^2} e^{-\frac{1}{2(\sigma^*)^2} \sum_{i=1}^k n_i [(\bar{z}_i - \mu_i^*)^2 + (\mu_i^* - \bar{x}_i)^2]} \left( \prod_{i=1}^k d\mu_i^* \right) \left( \prod_{i=1}^k d\bar{x}_i \right) dS_z^2 d(\sigma^*)^2. \end{aligned}$$

Note that  $(\bar{z}_i - \mu_i^*)^2 + (\mu_i^* - \bar{x}_i)^2 = \frac{(\bar{z}_i - \bar{x}_i)^2}{2} + 2 \left[ \mu_i^* - \frac{\bar{z}_i + \bar{x}_i}{2} \right]^2$ , integrating out  $\mu_1^*, \mu_2^*, \dots, \mu_k^*$  we get,

$$\begin{aligned} & f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \\ & \propto \int_{\bar{x}_1} \int_{\bar{x}_2} \dots \int_{\bar{x}_k} \int_0^\infty \int_0^\infty \frac{(S_z^2)^{\frac{N-k}{2}-1} (S_x^2)^{\frac{2N+\alpha-k-5}{2}}}{(\sigma^2)^{\frac{N}{2}} \{(\sigma^*)^2\}^{\frac{2N+\alpha-1}{2}}} e^{-\frac{S_z^2}{2(\sigma^*)^2}} e^{-\left[\frac{1}{\sigma^2} + \frac{1}{(\sigma^*)^2}\right] \frac{S_x^2}{2}} \\ & \times e^{-\frac{1}{2} \sum_{i=1}^k n_i \left[ \frac{(\bar{z}_i - \bar{x}_i)^2}{2(\sigma^*)^2} + \frac{(\bar{x}_i - \mu_i)^2}{\sigma^2} \right]} \left( \prod_{i=1}^k d\bar{x}_i \right) dS_z^2 d(\sigma^*)^2. \end{aligned}$$

Again we see that,

$$\begin{aligned} & \frac{(\bar{z}_i - \bar{x}_i)^2}{2(\sigma^*)^2} + \frac{(\bar{x}_i - \mu_i)^2}{\sigma^2} \\ & = \frac{(\bar{z}_i - \mu_i)^2}{\sigma^2 + 2(\sigma^*)^2} + \left( \frac{1}{\sigma^2} + \frac{1}{2(\sigma^*)^2} \right) \left[ \bar{x}_i - \frac{\mu_i}{\frac{1}{\sigma^2} + \frac{1}{2(\sigma^*)^2}} \right]^2. \end{aligned}$$

Integrating out  $\bar{x}_1, \bar{x}_2, \dots, \bar{x}_k$ , and after doing some simplifications we get,

$$\begin{aligned} & f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \\ & \propto \int_0^\infty \int_0^\infty \frac{(S_z^2)^{\frac{N-k}{2}-1} (S_x^2)^{\frac{2N+\alpha-k-5}{2}}}{(\sigma^2)^{\frac{N-k}{2}} \{(\sigma^*)^2\}^{\frac{2N+\alpha-k-1}{2}} (\sigma^2 + 2(\sigma^*)^2)^{\frac{k}{2}}} e^{-\frac{S_z^2}{2(\sigma^*)^2}} e^{-\left[\frac{1}{\sigma^2} + \frac{1}{(\sigma^*)^2}\right] \frac{S_x^2}{2}} \end{aligned}$$

$$\times e^{-\frac{1}{2} \sum_{i=1}^k \frac{n_i(\bar{z}_i - \mu_i)^2}{\sigma^2 + 2(\sigma^*)^2}} dS_z^2 d(\sigma^*)^2,$$

and thereafter integrating over  $S_x^2$  we get,

$$f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \propto \int_0^\infty \frac{(S_z^2)^{\frac{N-k}{2}-1} e^{-\frac{S_z^2}{2(\sigma^*)^2}} e^{-\frac{1}{2} \sum_{i=1}^k \frac{n_i(\bar{z}_i - \mu_i)^2}{\sigma^2 + 2(\sigma^*)^2}}}{(\sigma^2)^{-\frac{N+\alpha-3}{2}} (\sigma^*)^2 (\sigma^2 + (\sigma^*)^2)^{\frac{2N+\alpha-k-3}{2}} (\sigma^2 + 2(\sigma^*)^2)^{\frac{k}{2}}} d(\sigma^*)^2.$$

Finally making the transformation  $(\sigma^*)^2 \rightarrow \psi = \frac{\sigma^2}{(\sigma^*)^2}$  and after doing some simplifications we get,

$$f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2) \propto \frac{(S_z^2)^{\frac{N-k}{2}-1}}{(\sigma^2)^{\frac{N}{2}}} \int_0^\infty \frac{\psi^{\frac{2N+\alpha-5}{2}} e^{-\frac{\psi}{2\sigma^2} \left[ S_z^2 + \frac{1}{2+\psi} \sum_{i=1}^k n_i(\bar{z}_i - \mu_i)^2 \right]}}{(1+\psi)^{\frac{2N+\alpha-k-3}{2}} (2+\psi)^{\frac{k}{2}}} d\psi.$$

[Theorem (3.1) is proved]

The marginal distribution of  $\psi$  is given in the following theorem.

**Theorem 3.2.** *The marginal distribution of  $\psi$  is such that  $\left(\frac{N-k}{N+\alpha-3}\right) \psi \sim F_{N+\alpha-3, N-k}$ .*

*Proof.* The joint pdf of  $(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2, \psi)$  which can be found from Theorem(3.1) as,

$$f(\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k, S_z^2, \psi) \propto \frac{(S_z^2)^{\frac{N-k}{2}-1} \psi^{\frac{2N+\alpha-5}{2}} e^{-\frac{\psi}{2\sigma^2} \left[ S_z^2 + \frac{1}{2+\psi} \sum_{i=1}^k n_i(\bar{z}_i - \mu_i)^2 \right]}}{(\sigma^2)^{\frac{N}{2}} (1+\psi)^{\frac{2N+\alpha-k-3}{2}} (2+\psi)^{\frac{k}{2}}}.$$

Integrating over  $\bar{z}_1, \bar{z}_2, \dots, \bar{z}_k$  we get,

$$f(S_z^2, \psi) \propto \frac{\psi^{\frac{2N+\alpha-k-5}{2}} (S_z^2)^{\frac{N-k}{2}-1} e^{-\frac{\psi S_z^2}{2\sigma^2}}}{(\sigma^2)^{\frac{N-k}{2}} (1+\psi)^{\frac{2N+\alpha-k-3}{2}}},$$

and hence integrating over  $S_z^2$  we get the marginal pdf of  $\psi$  as,

$$\begin{aligned} f(\psi) &\propto \frac{\psi^{\frac{N+\alpha-3}{2}-1}}{(1+\psi)^{\frac{N+\alpha-3}{2} + \frac{N-k}{2}}}, \quad 0 < \psi < \infty \\ &= \frac{1}{B\left(\frac{N+\alpha-3}{2}, \frac{N-k}{2}\right)} \frac{\psi^{\frac{N+\alpha-3}{2}-1}}{(1+\psi)^{\frac{N+\alpha-3}{2} + \frac{N-k}{2}}}, \quad 0 < \psi < \infty, \end{aligned}$$

where  $B(a, b)$  is the beta function. Therefore  $\left(\frac{N-k}{N+\alpha-3}\right) \psi \sim F_{N+\alpha-3, N-k}$ . [Theorem (3.2) is proved]

The inferential results are discussed in the following remarks.

**Remark 3.1.** From theorem (3.1) it directly follows that conditionally given  $\psi$ ,

- i)  $\bar{z}_i \sim N\left(\mu_i, \frac{(2+\psi)\sigma^2}{n_i}\right)$ , independently for each  $i = 1, 2, \dots, k$ ,
- ii)  $\frac{\psi S_z^2}{\sigma^2} \sim \chi_{N-k}^2$ , independently of all  $\bar{z}_i$ 's ( $i = 1, 2, \dots, k$ ).

Defining  $\sigma_i^2 = \frac{(2+\psi)\sigma^2}{n_i}$  and  $\bar{\mu}_w = \frac{1}{N} \sum_{i=1}^k n_i \mu_i$  we get, for conditionally given  $\psi$ ,  $\sum_{i=1}^k \frac{(\bar{z}_i - \bar{\mu}_w)^2}{\sigma_i^2} = \frac{\text{BSS}(\mathbf{z})}{\sigma^2} \left(\frac{\psi}{2+\psi}\right)$  will follow a non-central chi-square distribution with degrees of freedom  $k-1$  and the non-centrality parameter be  $\lambda = \sum_{i=1}^k \frac{(\mu_i - \bar{\mu}_w)^2}{\sigma_i^2}$  and  $\frac{\psi}{\sigma^2} \text{WSS}(\mathbf{z}) \sim \chi_{N-k}^2$  independently of  $\text{BSS}(\mathbf{z})$ . To test the ANOVA problem given in (1) based on the synthetic data  $\mathbf{z} = (\mathbf{z}_1, \mathbf{z}_2, \dots, \mathbf{z}_k)$  as in the previous case, we define our test statistic under this method as  $F_z = \left(\frac{N-k}{k-1}\right) \frac{\text{BSS}(\mathbf{z})}{\text{WSS}(\mathbf{z})}$  which, conditionally given  $\psi$ , follows  $(2+\psi)$  times a non-central  $F$ -distribution with degrees of freedom  $(k-1, N-k)$  and with the non-centrality parameter  $\lambda$ . Note that  $\lambda = 0$  under  $H_0$  and hence  $F_z | \psi \sim (2+\psi) F_{k-1, N-k}$  under  $H_0$ . A level  $\gamma$  test based on the synthetic data  $\mathbf{z}$  for the testing problem (1) is given by  $F_z > D_{N,k,\alpha,\gamma}$ , where  $D_{N,k,\alpha,\gamma}$  is such that  $P[F_z > D_{N,k,\alpha,\gamma} | H_0] = \gamma$ . We obtain  $D_{N,k,\alpha,\gamma}$  by the following steps,

1. We can write,

$$\begin{aligned}\gamma &= P[F_z > D_{N,k,\alpha,\gamma} | H_0] \\ &= E_{H_0} [P(F_z > D_{N,k,\alpha,\gamma} | \psi)] \\ &= E_{H_0} \left[ P \left( F_{k-1,N-k} > \frac{D_{N,k,\alpha,\gamma}}{2+\psi} | \psi \right) \right]\end{aligned}$$

2. For a fixed  $D$ , to compute the expectation  $E_{H_0} \left[ P \left( F_{k-1,N-k} > \frac{D}{2+\psi} | \psi \right) \right]$ , we generate a large number of  $\psi$ 's such that  $\left( \frac{N-k}{N+\alpha-3} \right) \psi \sim F_{N+\alpha-3,N-k}$ , then compute  $P \left( F_{k-1,N-k} > \frac{D}{2+\psi} \right)$  for each of those  $\psi$ 's and take their simple arithmetic mean.

3. Finally we numerically solve  $E_{H_0} \left[ P \left( F_{k-1,N-k} > \frac{D}{2+\psi} | \psi \right) \right] - \gamma = 0$  for  $D$  to obtain  $D_{N,k,\alpha,\gamma}$ .

Different  $D_{N,k,\alpha,\gamma}$ 's are obtained for different sets of sample sizes which are provided in section 4.

**Remark 3.2.** The power of the test based on  $F_z$ , at a particular alternative point  $\boldsymbol{\mu} = (\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$  and  $\sigma = 1$  is given by  $\beta_{PPS}(\boldsymbol{\mu}) = P[F_z > D_{N,k,\alpha,\gamma} | \boldsymbol{\mu}]$ . Similar to the PIS case, here also we use Monte Carlo simulation to compute the powers. We generate a very large number ( $10^6$ ) of synthetic data sets by PPS method under a fixed choice of alternative  $\boldsymbol{\mu} = (\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$  and obtain the value of  $F_z$  for each of these data sets. The estimated power will be the proportion of the cases that the value of  $F_z$  exceeds the cutoff  $D_{N,k,\alpha,\gamma}$ . The powers for different sets of alternatives are provided in section 4.

## 4 Simulation Studies

In this section we provide a simulation study for comparison of power of the two  $F$ -tests proposed in Sections 2 and 3. We take  $k = 5$  and four choices of set of sample sizes as  $n_i = 10, i = 1(1)5$ ,  $n_i = 15, i = 1(1)5$ ,  $n_i = 20, i = 1(1)5$ , and  $n_1 = 10, n_2 = 10, n_3 = 15, n_4 = 20, n_5 = 25$ . In both PIS and PPS method we take  $\gamma = 0.05$  and in PPS method  $\alpha = 4$ . Five choices of set of alternatives  $(\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$  are taken as  $(0, 0, 0, 0, 0.5)$ ,  $(0, 0, 0, -0.5, 0.5)$ ,  $(0, -0.5, -0.5, 0.5, 0.5)$ ,  $(0, -1, -0.5, 0.5, 1)$ , and  $(0, -1, -1, 1, 1)$ . We use Monte Carlo simulation technique with  $S = 100000$  iterations to compute the powers. Following are the tables showing the cut-off points of the test statistics for different sets of sample sizes for both PIS and PPS methods and also the tables showing the powers of the tests for different choices of alternatives. Clearly the powers under PIS method are higher than those under PPS method.

Table 1: CUTOFF POINTS FOR DIFFERENT CHOICES OF SAMPLE SIZES UNDER PIS ( $k = 5, \gamma = 0.05, S = 100000$ )

$(n_1, n_2, n_3, n_4, n_5)$	$N$	$C_{N,k,\gamma}$
(10,10,10,10,10)	50	5.33159
(15,15,15,15,15)	75	5.12243
(20,20,20,20,20)	100	5.02934
(10,10,15,20,25)	80	5.08072



Table 2: CUTOFF POINTS FOR DIFFERENT CHOICES OF SAMPLE SIZES UNDER PPS ( $k = 5, \gamma = 0.05, \alpha = 4, S = 100000$ )

$(n_1, n_2, n_3, n_4, n_5)$	$N$	$D_{N,k,\alpha,\gamma}$
(10,10,10,10,10)	50	8.20283
(15,15,15,15,15)	75	7.78576
(20,20,20,20,20)	100	7.59969
(10,10,15,20,25)	80	7.77348

Table 3: TABLE SHOWING THE POWER FOR DIFFERENT CHOICES OF ALTERNATIVES AND DIFFERENT CHOICES OF SAMPLE SIZES UNDER PIS ( $k = 5, \gamma = 0.05, S = 100000$ )

$(\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$	$(n_1, n_2, n_3, n_4, n_5)$			
	(10,10,10,10,10)	(15,15,15,15,15)	(20,20,20,20,20)	(10,10,15,20,25)
(0,0,0,0,0.5)	0.09913	0.13102	0.16348	0.17448
(0,0,0,-0.5,0.5)	0.18898	0.27959	0.37456	0.41313
(0,-0.5,-0.5,0.5,0.5)	0.35557	0.53521	0.68064	0.57680
(0,-1,-0.5,0.5,1)	0.75660	0.92609	0.98118	0.94345
(0,-1,-1,1,1)	0.92926	0.99272	0.99930	0.99609

Table 4: TABLE SHOWING THE POWER FOR DIFFERENT CHOICES OF ALTERNATIVES AND DIFFERENT CHOICES OF SAMPLE SIZES UNDER PPS ( $k = 5, \gamma = 0.05, \alpha = 4, S = 100000$ )

$(\mu_1, \mu_2, \mu_3, \mu_4, \mu_5)$	$(n_1, n_2, n_3, n_4, n_5)$			
	(10,10,10,10,10)	(15,15,15,15,15)	(20,20,20,20,20)	(10,10,15,20,25)
(0,0,0,0,0.5)	0.08755	0.10629	0.12831	0.13636
(0,0,0,-0.5,0.5)	0.15121	0.21016	0.26993	0.29953
(0,-0.5,-0.5,0.5,0.5)	0.26855	0.39275	0.51015	0.42202
(0,-1,-0.5,0.5,1)	0.60137	0.79649	0.90669	0.82283
(0,-1,-1,1,1)	0.80836	0.94558	0.98722	0.96096

## 5 Disclosure Risk Evaluation

When the original (unit level) microdata is considered to be sensitive and thus hidden through the use of a masked version, it is natural to examine the extent to which sensitivity of a data point has been protected. A slight variation of a popular measure to study the disclosure risk of a single value  $x_i$  is given by (Klein and Sinha (2016) [16].)

$$P[|\hat{x}_i - x_i| < \epsilon | \mathbf{X}] = \theta_i$$

where  $\mathbf{X}$  is the entire original data, and  $\hat{x}_i$  is an intruder's prediction of  $x_i$  based upon seeing the released (artificial/synthetic) data,  $\epsilon$  be any small positive quantity. Naturally, a high value of the above probability indicates a low level of protection and vice versa. This measure is computed based on the random mechanism producing the masked data, given the original data  $\mathbf{X}$ .

Returning to our specific problem, the  $j^{th}$  observation from the  $i^{th}$  experiment, namely,  $x_{ij}$ , has been perturbed and replaced by  $y_{ij}$  under PIS and  $z_{ij}$  under PPS. We consider two cases: Case (1) - the label (unit) which produced the  $j^{th}$  item is identifiable and Case (2) - identity is lost. In Case (1), intruder's best guess about  $x_{ij}$  can be taken as  $y_{ij}$  (PIS) or  $z_{ij}$  (PPS). In Case (2), on the other hand, the intruder being unable to identify the  $j^{th}$  unit in  $i^{th}$  experiment, makes a guess  $\bar{y}_i$  (PIS) or  $\bar{z}_i$  (PPS) for the missing  $x_{ij}$  value.

The following theorem gives upper bounds to the disclosure risk both under PIS and PPS. Although it is quite possible to exactly compute the required disclosure risk probabilities for any unit (identifiable or not), the usefulness of the upper bounds lies in the merit that they provide the best case scenarios and also these bounds are independent of any specific responder, thus providing a uniform comparison under PIS and PPS.

**Theorem 5.1.** *Suppose  $\theta_{ij}$  be the disclosure risk for the  $j^{th}$  unit in the  $i^{th}$  experiment then, Case (1): (Units are identifiable)*

$$(a) \theta_{ij} \leq 2\Phi\left(\frac{\epsilon}{s_x}\right) - 1 \text{ (PIS)}$$

$$(b) \theta_{ij} \leq 2G_\nu\left(\frac{\epsilon}{s_x\sqrt{1+\frac{1}{n_i}}}\right) - 1 \text{ (PPS)}$$

*Case (2): (Units are unidentifiable)*

$$(a) \theta_{ij} \leq 2\Phi\left(\frac{\sqrt{n_i}\epsilon}{s_x}\right) - 1 \text{ (PIS)}$$

$$(b) \theta_{ij} \leq 2G_\nu\left(\frac{\epsilon}{s_x\sqrt{\frac{2}{n_i}}}\right) - 1 \text{ (PPS)}$$

where  $\phi(\cdot)$  is the pdf of a  $N(0, 1)$  distribution and  $g_\nu(\cdot)$  is the pdf of a  $t$ -distribution with  $\nu = N + \alpha - 3$  degrees of freedom and  $s_x^2 = \hat{\sigma}^2 = \frac{WSS}{(N-k)} = \frac{S_x^2}{N-k}$ .

*Proof.* Case (1): Here we assume that all the units of each experiments are identifiable. The disclosure risk for the  $j^{th}$  unit corresponding to the  $i^{th}$  experiment is given by

$$\theta_{ij} = P[|\hat{x}_{ij} - x_{ij}| < \epsilon | \mathbf{X}].$$

(a) Under PIS method, intruder's best guess about  $x_{ij}$  will be  $y_{ij}$ , that is  $\hat{x}_{ij} = y_{ij}, i = 1, 2, \dots, k; j = 1, 2, \dots, n_i$ . Now  $y_{ij} | \mathbf{X} \sim N(\bar{x}_i, s_x^2)$  for each  $j = 1, 2, \dots, n_i$  and  $i = 1, 2, \dots, k$ , therefore we can write,

$$\begin{aligned} \theta_{ij} &= P[|\hat{x}_{ij} - x_{ij}| < \epsilon | \mathbf{X}] \\ &= P[|y_{ij} - x_{ij}| < \epsilon | \mathbf{X}] \\ &= P[-\epsilon < y_{ij} - x_{ij} < \epsilon | \mathbf{X}] \\ &= P\left[\frac{-\epsilon - (\bar{x}_i - x_{ij})}{s_x} < Z < \frac{\epsilon - (\bar{x}_i - x_{ij})}{s_x}\right] \\ &\text{(where } Z \text{ is a } N(0, 1) \text{ variate.)} \\ &= P[-\eta + \delta_{ij} < Z < \eta + \delta_{ij}] \\ &\text{(writing } \eta = \frac{\epsilon}{s_x} \text{ and } \delta_{ij} = \frac{x_{ij} - \bar{x}_i}{s_x}) \\ &= \Phi(\eta + \delta) - \Phi(-\eta + \delta) \\ &\text{(\Phi be the CDF of } N(0, 1) \text{ distribution.)} \\ &\leq \Phi(\eta) - \Phi(-\eta) \\ &= 2\Phi(\eta) - 1. \end{aligned}$$

(b) Under PPS method, intruder's best guess about  $x_{ij}$  will be  $z_{ij}$ , that is  $\hat{x}_{ij} = z_{ij}, i = 1, 2, \dots, k; j = 1, 2, \dots, n_i$ . Now  $z_{ij} | \mu_i^*, (\sigma^*)^2 \sim N(\mu_i^*, (\sigma^*)^2)$  for each  $j = 1, 2, \dots, n_i$  and  $i = 1, 2, \dots, k$ , where  $\mu_i^* | (\sigma^*)^2 \sim N(\bar{x}_i, \frac{(\sigma^*)^2}{n_i})$ , independently for each  $i = 1, 2, \dots, k$  and  $\frac{S_x^2}{(\sigma^*)^2} \sim \chi_\nu^2$  ( $\nu = N + \alpha - 3$ ).

In order to find the disclosure risk  $\theta_{ij} = P[|z_{ij} - x_{ij}| < \epsilon | \mathbf{X}]$ , we need to find the marginal distribution of  $z_{ij} | \mathbf{X}$ . The joint pdf of  $(z_{ij}, \mu_i^*, (\sigma^*)^2)$  has the pdf of the form,

$$\begin{aligned} f(z_{ij}, \mu_i^*, (\sigma^*)^2) &= f(z_{ij} | \mu_i^*, (\sigma^*)^2) \times f(\mu_i^* | (\sigma^*)^2) \times f((\sigma^*)^2) \\ &\propto \frac{(S_x^2)^{\frac{\nu}{2}}}{[(\sigma^*)^2]^{\frac{\nu}{2}+2}} e^{-\frac{S_x^2}{2(\sigma^*)^2}} e^{-\frac{1}{2(\sigma^*)^2} [(z_{ij} - \mu_i^*)^2 + n_i(\mu_i^* - \bar{x}_i)^2]}. \end{aligned}$$

Note that,

$$(z_{ij} - \mu_i^*)^2 + n_i(\mu_i^* - \bar{x}_i)^2 = (n_i + 1) \left[ \mu_i^* - \frac{z_{ij} + n_i \bar{x}_i}{n_i + 1} \right]^2 + \frac{n_i(z_{ij} - \bar{x}_i)^2}{n_i + 1}.$$

Therefore integrating the joint pdf over  $\mu_i^*$  and then over  $(\sigma^*)^2$  we get the marginal pdf of  $z_{ij}$  given the data as,

$$f(z_{ij} | \mathbf{X}) \propto \int_0^\infty \frac{(S_x^2)^{\frac{\nu}{2}} e^{-\frac{S_x^2}{2(\sigma^*)^2}}}{[(\sigma^*)^2]^{\frac{\nu}{2}+1}} \times \frac{e^{-\frac{n_i}{2(n_i+1)(\sigma^*)^2} (z_{ij} - \bar{x}_i)^2}}{\sigma^*} d(\sigma^*)^2.$$

From the above expression of the marginal pdf we can write,

1.  $z_{ij} | (\sigma^*)^2, \mathbf{X} \sim N\left(\bar{x}_i, \frac{(n_i+1)(\sigma^*)^2}{n_i}\right) \Rightarrow \frac{z_{ij} - \bar{x}_i}{\sigma^* \sqrt{1 + \frac{1}{n_i}}} | (\sigma^*)^2, \mathbf{X} \sim N(0, 1),$
2.  $\frac{S_x^2}{(\sigma^*)^2} | \mathbf{X} \sim \chi_\nu^2.$

Defining  $s_x^2 = \frac{S_x^2}{\nu}$ , we can write

$$\frac{z_{ij} - \bar{x}_i}{s_x \sqrt{1 + \frac{1}{n_i}}} | \mathbf{X} \sim t_\nu.$$

Finally the disclosure risk can be written as,

$$\begin{aligned} \theta_{ij} &= P[|z_{ij} - x_{ij}| < \epsilon | \mathbf{X}] \\ &= P[-\epsilon + x_{ij} < z_{ij} < \epsilon + x_{ij} | \mathbf{X}] \\ &= P\left[\frac{-\epsilon + x_{ij} - \bar{x}_i}{s_x \sqrt{1 + \frac{1}{n_i}}} < t_\nu < \frac{\epsilon + x_{ij} - \bar{x}_i}{s_x \sqrt{1 + \frac{1}{n_i}}}\right] \\ &\text{where } t_\nu \text{ follows a } t\text{-distribution with } \nu \text{ degrees of freedom.} \\ &= G_\nu(\eta_i + \zeta_{ij}) - G_\nu(-\eta_i + \zeta_{ij}) \\ &\text{(writing } \eta_i = \frac{\epsilon}{s_x \sqrt{1 + \frac{1}{n_i}}} \text{ and } \zeta_{ij} = \frac{x_{ij} - \bar{x}_i}{s_x \sqrt{1 + \frac{1}{n_i}}}) \\ &\leq G_\nu(\eta_i) - G_\nu(-\eta_i) \\ &[G_\nu(\cdot) \text{ is the CDF of a } t\text{-distribution with } \nu \text{ degrees of freedom}] \\ &= 2G_\nu(\eta_i) - 1. \end{aligned}$$

Case (2): Here the identities of  $j^{th}$  unit ( $j = 1, 2, \dots, n_i$ ) corresponding to the  $i^{th}$  experiment ( $i = 1, 2, \dots, k$ ) are lost, hence the intruder's best guess about  $x_{ij}$  will be taken as  $\bar{y}_i$  for PIS and  $\bar{z}_i$  for PPS. The disclosure risk for the  $j^{th}$  unit corresponding to the  $i^{th}$  experiment is given by

$$\begin{aligned} \theta_{ij} &= P[|\hat{x}_{ij} - x_{ij}| < \epsilon | \mathbf{X}] \\ &= \begin{cases} P[|\bar{y}_i - x_{ij}| < \epsilon | \mathbf{X}] & \text{(PIS)} \\ P[|\bar{z}_i - x_{ij}| < \epsilon | \mathbf{X}] & \text{(PPS)}. \end{cases} \end{aligned}$$

(a) Note that,  $\bar{y}_i | \mathbf{X} \sim N(\bar{x}_i, \frac{s_x^2}{n_i})$  for  $i = 1, 2, \dots, k$ , and hence the disclosure risk under PIS is given by

$$\theta_{ij} = P[|\bar{y}_i - x_{ij}| < \epsilon | \mathbf{X}]$$

$$\begin{aligned}
&= P[-\epsilon < \bar{y}_i - x_{ij} < \epsilon | \mathbf{X}] \\
&= P \left[ \frac{-\epsilon + (x_{ij} - \bar{x}_i)}{\frac{s_x}{\sqrt{n_i}}} < Z < \frac{-\epsilon + (x_{ij} - \bar{x}_i)}{\frac{s_x}{\sqrt{n_i}}} \right] \\
&\text{(where } Z \text{ is a } N(0, 1) \text{ variate.)} \\
&= P[-\eta_i + \delta_{ij} < Z < \eta_i + \delta_{ij}] \\
&\text{(writing } \eta_i = \frac{\sqrt{n_i}\epsilon}{s_x} \text{ and } \delta_{ij} = \frac{\sqrt{n_i}(x_{ij} - \bar{x}_i)}{s_x}) \\
&= \Phi(\eta_i + \delta_{ij}) - \Phi(-\eta_i + \delta_{ij}) \\
&\text{(\Phi be the CDF of } N(0, 1) \text{ distribution.)} \\
&\leq \Phi(\eta_i) - \Phi(-\eta_i) \\
&= 2\Phi(\eta_i) - 1.
\end{aligned}$$

(b) To derive the disclosure risk under PPS, we need to find the marginal distribution of  $\bar{z}_i | \mathbf{X}$ . Now  $\bar{z}_i | \mu_i^*, (\sigma^*)^2 \sim N(\mu_i^*, \frac{(\sigma^*)^2}{n_i})$  for  $i = 1, 2, \dots, k$ , where  $\mu_i^* | (\sigma^*)^2 \sim N(\bar{x}_i, \frac{(\sigma^*)^2}{n_i})$ , independently for each  $i = 1, 2, \dots, k$  and  $\frac{S_x^2}{(\sigma^*)^2} \sim \chi_\nu^2$  ( $\nu = N + \alpha - 3$ ). The joint pdf of  $(\bar{z}_i, \mu_i^*, (\sigma^*)^2)$  has the pdf of the form,

$$\begin{aligned}
f(\bar{z}_i, \mu_i^*, (\sigma^*)^2) &= f(\bar{z}_i | \mu_i^*, (\sigma^*)^2) \times f(\mu_i^* | (\sigma^*)^2) \times f((\sigma^*)^2) \\
&\propto \frac{(S_x^2)^{\frac{\nu}{2}}}{[(\sigma^*)^2]^{\frac{\nu}{2}+2}} e^{-\frac{S_x^2}{2(\sigma^*)^2}} e^{-\frac{n_i}{2(\sigma^*)^2}[(\bar{z}_i - \mu_i^*)^2 + (\mu_i^* - \bar{x}_i)^2]}.
\end{aligned}$$

Note that,

$$(z_{ij} - \mu_i^*)^2 + (\mu_i^* - \bar{x}_i)^2 = 2 \left[ \mu_i^* - \frac{\bar{z}_i + \bar{x}_i}{2} \right]^2 + \frac{(\bar{z}_i - \bar{x}_i)^2}{2}.$$

Integrating the joint pdf over  $\mu_i^*$  and then over  $(\sigma^*)^2$  we get the marginal pdf of  $\bar{z}_i$  given the data as,

$$f(\bar{z}_i | \mathbf{X}) \propto \int_0^\infty \frac{(S_x^2)^{\frac{\nu}{2}} e^{-\frac{S_x^2}{2(\sigma^*)^2}}}{[(\sigma^*)^2]^{\frac{\nu}{2}+1}} \times \frac{e^{-\frac{n_i}{4(\sigma^*)^2}(\bar{z}_i - \bar{x}_i)^2}}{\sigma^*} d(\sigma^*)^2.$$

From the above expression of the marginal pdf we can write,

1.  $\bar{z}_i | (\sigma^*)^2, \mathbf{X} \sim N\left(\bar{x}_i, \frac{2(\sigma^*)^2}{n_i}\right) \Rightarrow \frac{\sqrt{n_i}(\bar{z}_i - \bar{x}_i)}{\sigma^* \sqrt{2}} | (\sigma^*)^2, \mathbf{X} \sim N(0, 1),$
2.  $\frac{S_x^2}{(\sigma^*)^2} | \mathbf{X} \sim \chi_\nu^2.$

Defining  $s_x^2 = \frac{S_x^2}{\nu}$ , we can write

$$\frac{\sqrt{n_i}(\bar{z}_i - \bar{x}_i)}{s_x \sqrt{2}} | \mathbf{X} \sim t_\nu.$$

Therefore the disclosure risk under PPS can be written as,

$$\begin{aligned}
\theta_{ij} &= P[|\bar{z}_i - x_{ij}| < \epsilon | \mathbf{X}] \\
&= P[-\epsilon + x_{ij} < \bar{z}_i < \epsilon + x_{ij} | \mathbf{X}] \\
&= P \left[ \frac{-\epsilon + x_{ij} - \bar{x}_i}{s_x \sqrt{\frac{2}{n_i}}} < t_\nu < \frac{\epsilon + x_{ij} - \bar{x}_i}{s_x \sqrt{\frac{2}{n_i}}} \right] \\
&\text{where } t_\nu \text{ follows a } t\text{-distribution with } \nu \text{ degrees of freedom.} \\
&= G_\nu(\eta_i + \zeta_{ij}) - G_\nu(-\eta_i + \zeta_{ij}) \\
&\text{(writing } \eta_i = \frac{\epsilon}{s_x \sqrt{\frac{2}{n_i}}} \text{ and } \zeta_{ij} = \frac{x_{ij} - \bar{x}_i}{s_x \sqrt{\frac{2}{n_i}})} \\
&\leq G_\nu(\eta_i) - G_\nu(-\eta_i).
\end{aligned}$$

$$[G_\nu(.) \text{ is the CDF of a } t\text{-distribution with } \nu \text{ degrees of freedom}]$$

$$= 2G_\nu(\eta_i) - 1.$$

[Theorem (5.1) is proved]

Next we compute the upper bounds to the disclosure risks under PIS and PPS methods for both case (1) and (2) by taking suitable choices of  $\epsilon, s_x$  and different sample sizes for different experiments. Here we have taken  $\epsilon = 0.1$ ,  $s_x = 5, 10, 15, 20$  and the sample sizes for three independent experiments as  $n_1 = 10, n_2 = 15$  and  $n_3 = 20$ . The tables are given below.

Table 5: TABLE SHOWING THE UPPER BOUND TO THE DISCLOSURE RISKS UNDER CASE (1) [ALL UNITS ARE IDENTIFIABLE] ( $\epsilon = 0.1, \alpha = 4, k = 3$ )

EXPERIMENTS ( $k = 3$ )	$s_x$							
	5		10		15		20	
	PIS	PPS	PIS	PPS	PIS	PPS	PIS	PPS
EXPERIMENT - 1 ( $n_1 = 10$ )	0.01595	0.01513	0.00798	0.00756	0.00532	0.00504	0.00399	0.00378
EXPERIMENT - 2 ( $n_2 = 15$ )	0.01595	0.01536	0.00798	0.00768	0.00532	0.00512	0.00399	0.00384
EXPERIMENT - 3 ( $n_3 = 20$ )	0.01595	0.01549	0.00798	0.00774	0.00532	0.00516	0.00399	0.00387

Table 6: TABLE SHOWING THE UPPER BOUND TO THE DISCLOSURE RISKS UNDER CASE (2) [UNITS ARE UNIDENTIFIABLE] ( $\epsilon = 0.1, \alpha = 4, k = 3$ )

EXPERIMENTS ( $k = 3$ )	$s_x$							
	5		10		15		20	
	PIS	PPS	PIS	PPS	PIS	PPS	PIS	PPS
EXPERIMENT - 1 ( $n_1 = 10$ )	0.05043	0.03548	0.02523	0.01774	0.01682	0.01183	0.01261	0.00887
EXPERIMENT - 2 ( $n_2 = 15$ )	0.06174	0.04344	0.03089	0.02173	0.02060	0.01449	0.01545	0.01087
EXPERIMENT - 3 ( $n_3 = 20$ )	0.07127	0.05015	0.03567	0.02509	0.02378	0.01673	0.01784	0.01255

## 6 Concluding Remarks

From the tables given in section 5 we can see that, larger the value of WSS [  $WSS = (N - k)s_x^2$  ], lower the disclosure risk, on the other hand as WSS becomes larger the inference will be less efficient. From table (5) and table (6) we can conclude that PPS method gives a better privacy protection than the PIS method throughout for each choice of  $s_x$  and each experiment. On the other hand, from table (3) and table (4) it is clear that the powers at different choices of alternatives are larger for the test under PIS method than the PPS method. Therefore accuracy of inference and privacy protection work in opposite direction. In this paper we have used the usual F-statistic based on the synthetic data to carry out the tests for both PIS and PPS, but it is desirable to derive the Likelihood Ratio Test (LRT) for each of them. We wish to take it up in the future.

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